

<b>Notice of References Cited</b>	Application/Control No. 09/558,598	Applicant(s)/Patent Under Reexamination MAEDA, KEIJI	
	Examiner John Pezzlo	Art Unit 2662	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,754,210 B1	06-2004	Ofek, Yoram	370/389
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

**Notice of References Cited**Application/Control No.  
09/558,598Applicant(s)/Patent Under  
Reexamination  
MAEDA, KEIJIExaminer  
Timothy LeeArt Unit  
2697

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,822,321 A	10-1998	Petersen et al.	370/474
	B	US-6,084,889 A	07-2000	Murakami, Masaru	370/474
	C	US-5,978,375 A	11-1999	Petersen et al.	370/395.6
	D	US-6,081,533 A	06-2000	Laubach et al.	370/421
	E	US-5,799,017	08-1998	Gupta et al.	370/419
	F	US-6,041,054 A	03-2000	Westberg, Lars	370/389
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.